

Features

- Super Low Gate Charge
- 100% EAS Guaranteed
- Green Device Available
- Excellent CdV/dt effect decline
- Advanced high cell density Trench technology

BVDSS		100	V
ID@VGS= 10V , TC=25°C		70	A
RDSON(MAX)	VGS = 10 V , ID = 20 A	10	mΩ
	VGS = 4.5 V , ID = 15 A	13	

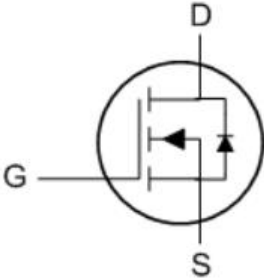
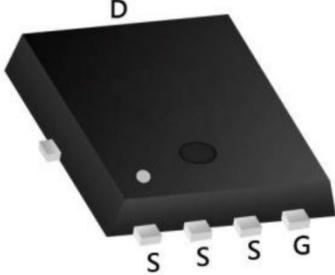
Application

- MB/VGA Vcore
- SMPS 2nd Synchronous Rectifier
- POL application
- BLDC Motor driver

Description

The JSBA78N10 is the high cell density trenched N-Ch MOSFETs, which provide excellent RDSON and gate charge for most of the Synchronous Rectifier applications.

The JSBA78N10 meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Equivalent Circuit	Outline
	<p>PRPAK5×6</p> 

Package Marking and Ordering Information

Device Marking	Date Code	Device Package	Quantity
A078N10	YWWXXX	PRPAK5×6	5000 pcs

Thermal Characteristic

Symbol	Parameter	Value	Unit
$R_{\theta JA}$	Thermal Resistance Junction-Ambient ¹	20	°C/W
$R_{\theta JC}$	Thermal Resistance Junction-Case ¹	1.3	°C/W

Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit
V_{DS}	Drain-Source Voltage	100	V
V_{GS}	Gate-Source Voltage	±20	V
I_D	Continuous Drain Current, $V_{GS} @ 10V$ ¹ ($T_C=25^\circ C$)	70	A
	Continuous Drain Current, $V_{GS} @ 10V$ ¹ ($T_C=100^\circ C$)	44	
	Continuous Drain Current, $V_{GS} @ 10V$ ¹ ($T_A=25^\circ C$)	18	
	Continuous Drain Current, $V_{GS} @ 10V$ ¹ ($T_A=70^\circ C$)	14.3	
I_{DM}	Pulsed Drain Current ²	280	A
P_D	Total Power Dissipation ⁴ ($T_C=25^\circ C$)	96	W
	Total Power Dissipation ⁴ ($T_C=100^\circ C$)	38	
	Total Power Dissipation ⁴ ($T_A=25^\circ C$)	6.25	
	Total Power Dissipation ⁴ ($T_A=70^\circ C$)	4	
E_{AS}	Single Pulse Avalanche Energy ³	196	mJ
I_{AS}	Avalanche Current	28	A
T_J, T_{STG}	Operating Junction and Storage Temperature Range	-55 To 150	°C

Electrical Characteristics ($T_J=25^\circ C$ unless otherwise noted)

Static Characteristics						
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250 \mu A$	100			V
$R_{DS(ON)}$	Drain-Source On-State Resistance ²	$V_{GS} = 10V, I_D = 20A$		7.8	10	mΩ
		$V_{GS} = 4.5V, I_D = 15A$		10	13	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.2	1.6	2.2	V
I_{DSS}	Drain-Source Leakage Current ($T_J=25^\circ C$)	$V_{DS} = 100V, V_{GS} = 0V$			1	μA
	Drain-Source Leakage Current ($T_J=55^\circ C$)	$V_{DS} = 100V, V_{GS} = 0V$			5	
I_{GSS}	Gate-Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA
g_{fs}	Forward Transconductance	$V_{DS} = 5V, I_D = 15A$		27		S
R_g	Gate Resistance	$V_{DS} = 0V, V_{GS} = 0V, f=1MHz$		1.4		Ω

Dynamic Characteristics						
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
C_{iss}	Input Capacitance	$V_{DS} = 40\text{ V}$		2433		pF
C_{oss}	Output Capacitance	$V_{GS} = 0\text{ V}$		631		pF
C_{rss}	Reverse Transfer Capacitance	$f=1.0\text{MHz}$		27		pF
Switching Times						
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 50\text{ V}$		10.9		nS
t_r	Turn-On Rise Time	$V_{GS} = 10\text{ V}$		16		nS
$t_{d(off)}$	Turn-Off Delay Time	$R_G = 6\ \Omega$		40		nS
t_f	Turn-Off Fall Time	$I_D = 10\text{ A}$		26		nS
Q_g	Total Gate Charge (10 V)	$V_{DS} = 50\text{ V}$		26		nC
Q_{gs}	Gate-Source Charge	$V_{GS} = 10\text{ V}$		10		nC
Q_{gd}	Gate-Drain Charge	$I_D = 12\text{ A}$		5.3		nC

Source-Drain Diode Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
I_S	Continuous Source Current ^{1,5}	$V_G=V_D=0\text{V}$, Force Current			70	A
V_{SD}	Diode Forward Voltage ²	$I_S = 20\text{ A}$, $V_{GS}=0\text{V}$, $T_J=25^\circ\text{C}$			1.2	V
t_{rr}	Reverse Recovery Time	$I_F = 20\text{ A}$, $di/dt = 100\text{A}/\mu\text{s}$,		50		nS
Q_{rr}	Reverse Recovery Charge	$T_J=25^\circ\text{C}$		70		nC

Notes:

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed : Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.
- 3.The E_{AS} data shows Max. rating . The test condition is $V_{DD} = 25\text{ V}$, $V_{GS} = 10\text{ V}$, $L = 0.5\text{ mH}$, $I_{AS} = 28\text{ A}$.
- 4.The power dissipation is limited by 150°C junction temperature.
- 5.The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

Typical Characteristics

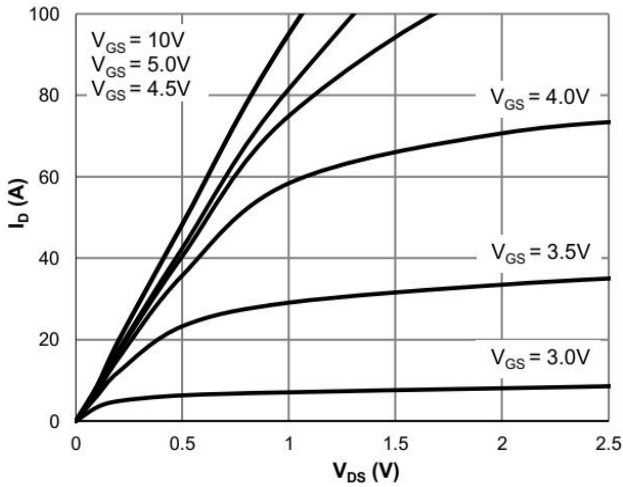


Fig.1 Typical Output Characteristics

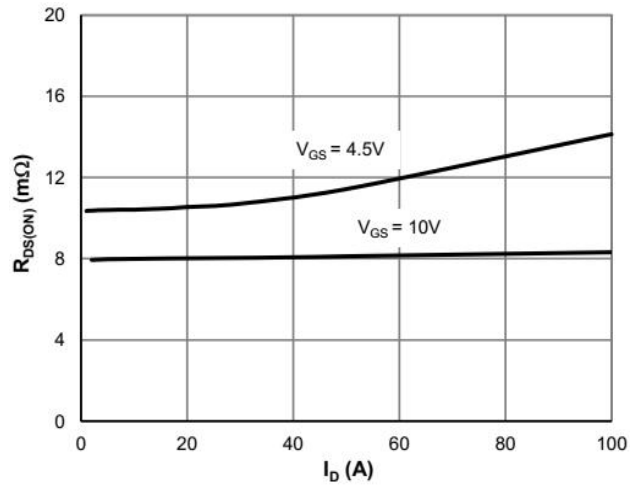


Fig.2 On-Resistance vs. Drain Current

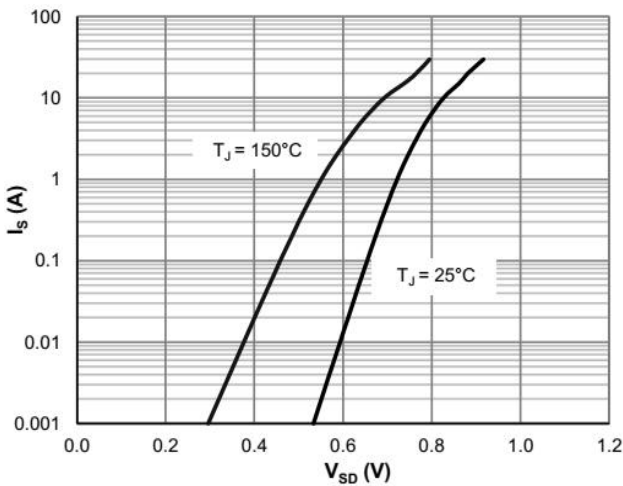


Fig.3 Forward Characteristics Of Reverse

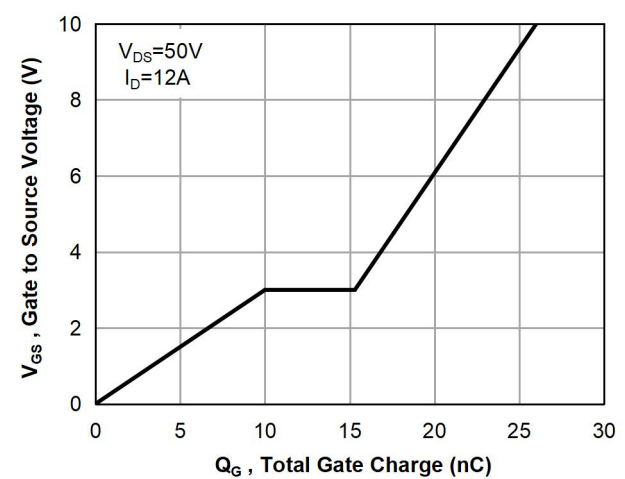


Fig.4 Gate-Charge Characteristics

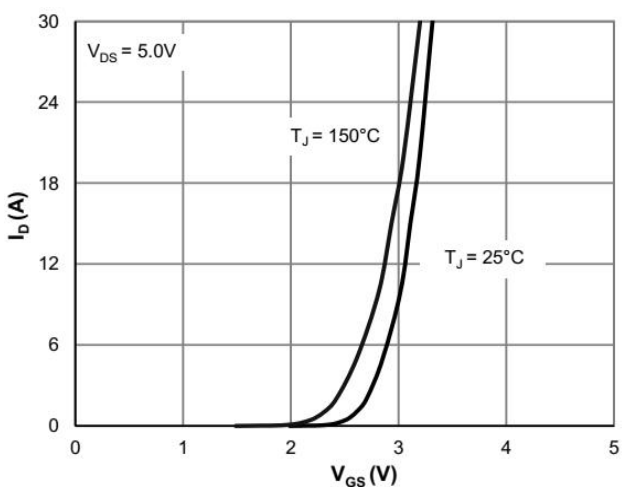


Fig.5 Transfer Characteristics

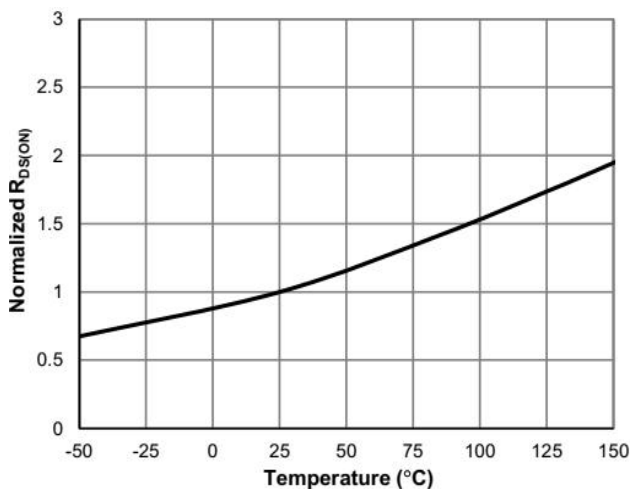


Fig.6 Normalized $R_{DS(on)}$ vs. T_J

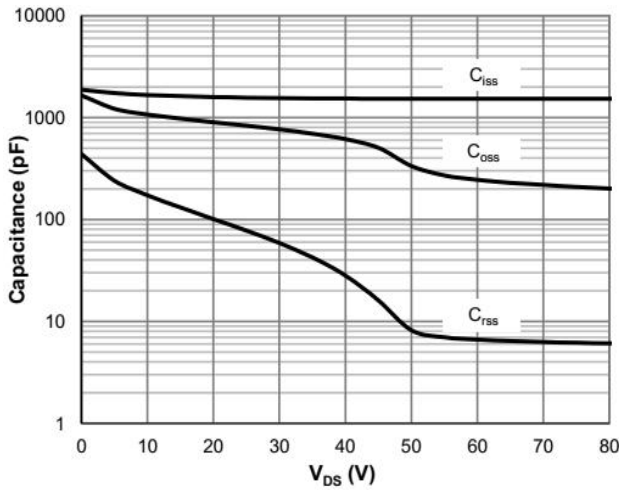


Fig.7 Capacitance

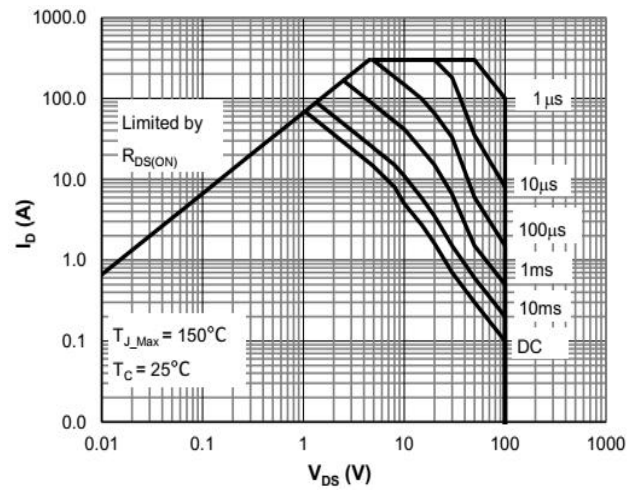


Fig.8 Safe Operating Area

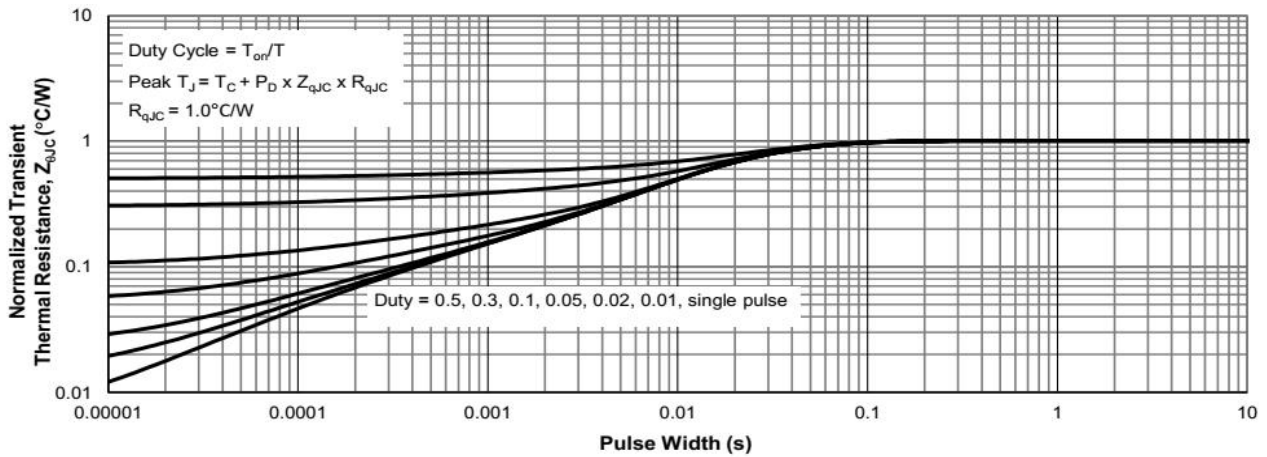


Fig.9 Normalized Maximum Transient Thermal Impedance

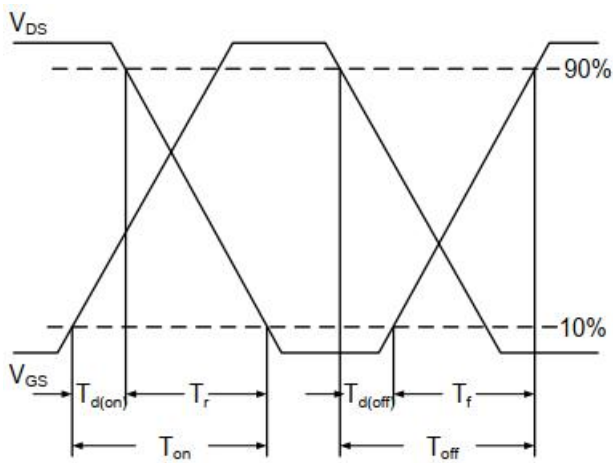


Fig.10 Switching Time Waveform

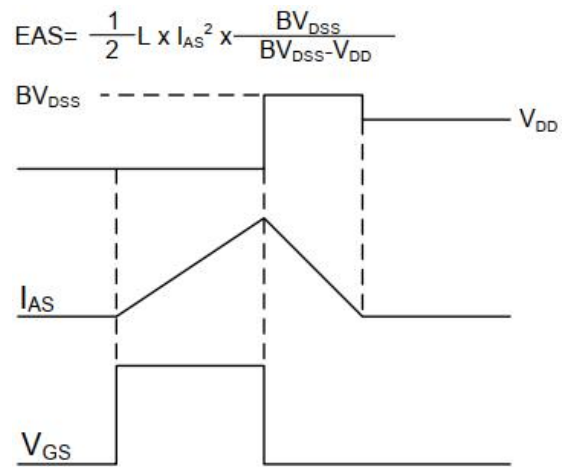
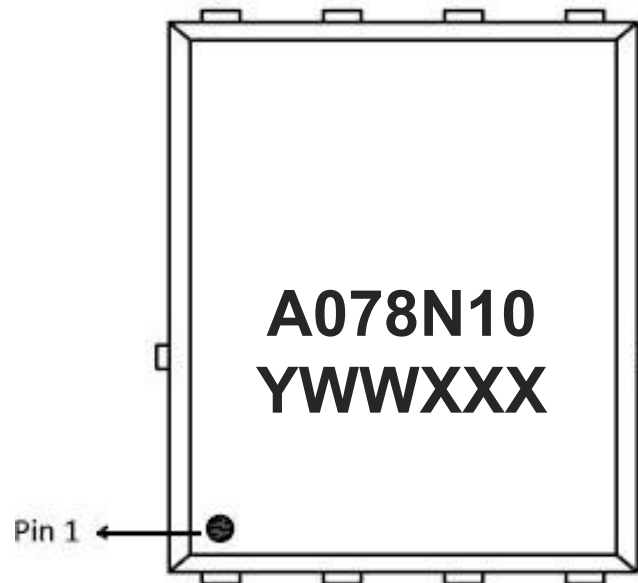


Fig.11 Unclamped Inductive Switching Waveform

Marking Information

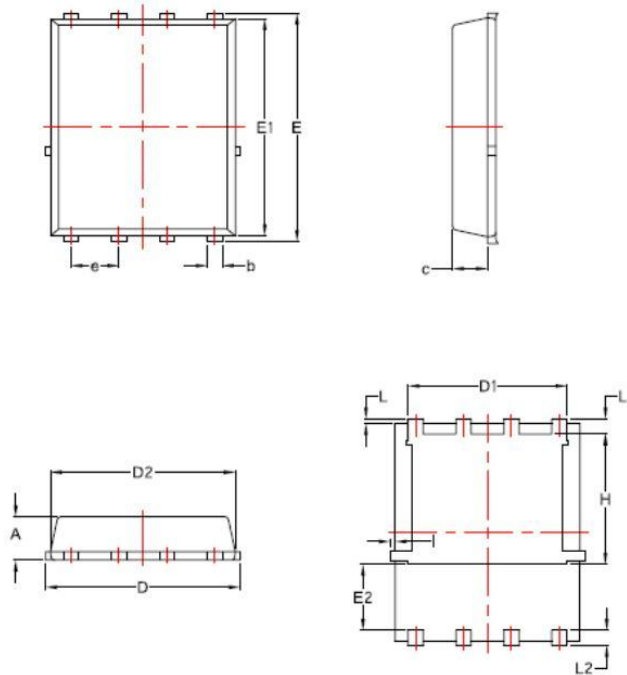


1st line: Device Package, Part Number, Channel and Version

2nd line: Date Code [Y WW XX X]

- ① **Y** : Year (2021=M, 2022=N.....)
- ② **WW** : Week (01-53)
- ③ **XX** : Serial Number (01-99, AA-ZZ)
- ④ **X** : Factory Code (A-Z)

PRPAK5×6 Package Outline



SYMBOLS	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	0.90	1.20	0.0354	0.0474
b	0.30	0.51	0.0118	0.0200
c	0.60	1.046	0.0236	0.0412
D1	4.11	4.31	0.1618	0.1697
D2	4.80	5.20	0.1890	0.2047
E	5.90	6.35	0.2323	0.2500
E1	5.65	6.06	0.2224	0.2386
E2	1.10	-	0.0433	-
e	1.27 BSC		0.05 BSC	
L	0.05	0.25	0.0020	0.0098
L1	0.38	0.61	0.0150	0.0240
L2	0.30	0.71	0.0118	0.0280
H	3.30	3.92	0.1300	0.1543
I	-	0.18	-	0.0070